

# **Enhancement Mode N-Channel Power MOSFET**

 $TO-252/NMOS/650V/\pm30V/3V/4A/2.3\Omega$ 

Rev<sub>0.9</sub>





## 650V,2.3Ω, 4A, N-Channel MOSFET

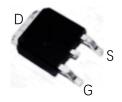
#### 1.Features

- New technology for high voltage device
- ◆ Low on-resistance and low conduction losses
- Ultra Low Gate Charge cause lower driving requirements

V <sub>DS</sub> Typ.	R <sub>DS(on)</sub> Typ.	I <sub>D</sub> Max.
650V	2.3Ω @ 10V	4A

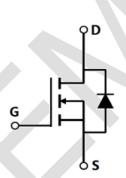
#### 2.Applications

- Power factor correction
- Switched mode power supplies
- ◆ Uninterruptible Power Supply



Pin Description

TO-252



Schematic Diagram

#### 3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP4N65KD	WP4N65	TO-252	2,500	25,000

#### 4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V <sub>DSS</sub>	650	V
Gate to Source Voltage	V <sub>GSS</sub>	±30	V
Drain Current-Continuous	ID	4	Α
Drain Current (Pulse)	Ірм	16	Α
Single Pulsed Avalanche Energy	Eas	155	mJ
Maximum Power Dissipation	Po	28.4	W
Operating Junction and Storage Temperature Range	Tj, Tstg	-55 to +160	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



#### 5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction to Case	Rejc	4.4	°C/W

Note 2: When mounted on 1 inch square copper board  $t \le 10$ sec The value in any given application depends on the user's specific board design.

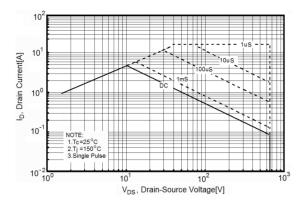
### 6.Electrical Characteristics at Ta=25°C (Note 3)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V <sub>(BR)DSS</sub>	I <sub>D</sub> = 250μA, V <sub>GS</sub> = 0V	650			V
Zero-Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 650V, V <sub>GS</sub> = 0V			1	μA
Gate-Body Leakage Current	Igss	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =250µA	2.4	3.0	4.0	V
Drain to Source On-State Resistance	R <sub>DS(on)</sub>	I <sub>D</sub> = 2A, V <sub>GS</sub> = 10V		2.3	2.5	Ω
Input Capacitance	Ciss	V <sub>GS</sub> =0V,		304		pF
Output Capacitance	Coss	V <sub>DS</sub> =50V,		18		pF
Reverse Transfer Capacitance	Crss	Frequency=1.0MHz		0.6		pF
Turn-ON Delay Time	t <sub>d(on)</sub>			8		ns
Turn-ON Rise Time	tr	V <sub>DD</sub> = 380V, V <sub>GS</sub> =		4		ns
Turn-OFF Delay Time	t <sub>d(off)</sub>	10V, $R_{GEN} = 5Ω$ , $I_D =$ 2.5A		52		ns
Turn-ON Fall Time	t <sub>f</sub>			9		ns
Total Gate Charge	Qg	V <sub>DS</sub> = 480V,		8.8		nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10V,		2.3		nC
Gate-Drain Charge	Qgd	I <sub>D</sub> = 4A		4		nC
Diode Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> = 4A, V <sub>GS</sub> = 0V	0.55	0.8	1.1	V
Maximum Continuous Drain to Source Diode Forward Curren	ls	-	-	-	4	Α
Maximum Pulsed Drain to Source Diode Forward Current	Isм	-	-	-	16	Α
Body Diode Reverse Recovery Time	trr	I <sub>F</sub> =2A,	-	200	-	nS
Body Diode Reverse Recovery Charg	Qrr	di/dt=100A/μs	-	0.6	-	nC

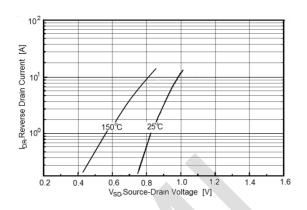
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



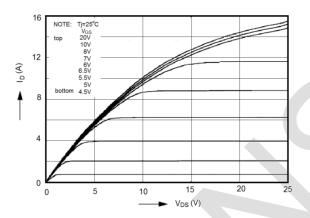
## 7. Typical electrical and thermal characteristics



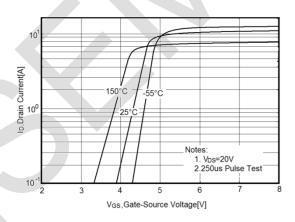
Safe operating area



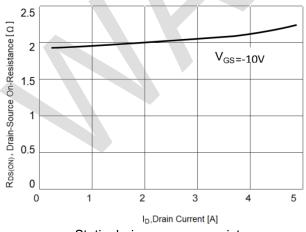
Source-Drain Diode Forward Voltage



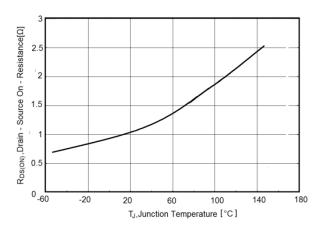
**Output Characteristics** 



Typical Transfer Characteristics

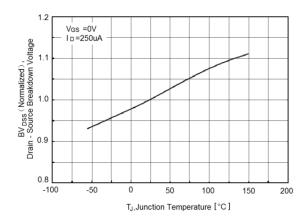


Static drain-source on resistance

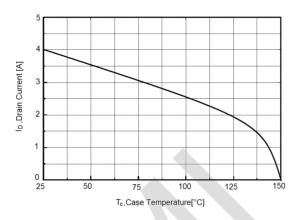


 $R_{DS(on)}$  vs Junction Temperature

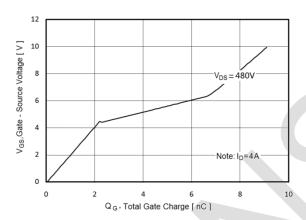




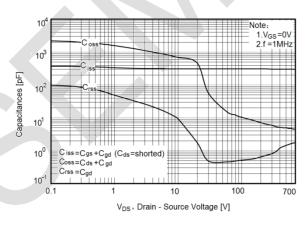
BV<sub>DSS</sub> vs Junction Temperature



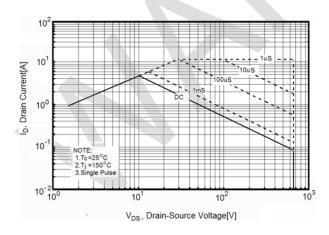
Maximum Id vs Junction Temperature



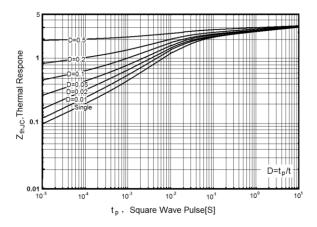
Gate charge waveforms



Capacitance



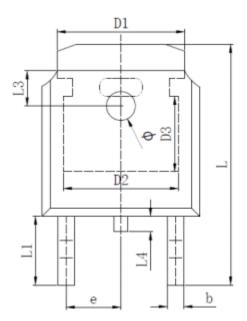
Safe operating area

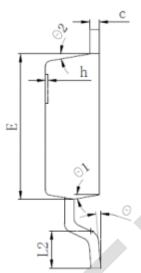


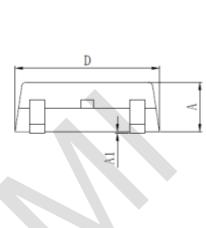
Transient Thermal Impedance



# 8.Package Dimensions







SYMBOL		MILLIMETER			
SIMBOL	MIN	Typ.	MAX		
A	2. 200	2.300	2. 400		
A1	0.000		0. 127		
b	0.640	0.690	0.740		
c(电镀后)	0. 460	0.520	0.580		
D	6. 500	6.600	6. 700		
D1	5. 334 REF				
D2	4.826 REF				
D3		3.166 REF			
E	6. 000	6. 100	6. 200		
e	2.286 TYP				
h	0.000	0.100	0. 200		
L	9. 900	10. 100	10.300		
L1	2.888 REF				
L2	1.400	1.550	1. 700		
L3	1.600 REF				
L4	0.600	0.800	1.000		
ф	1. 100	1.200	1.300		
θ	0°		8°		
θ1	9° TYP				
θ2	9° TYP				



#### 9.Important Notice

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